

# SLP16N50C / SLF16N50C

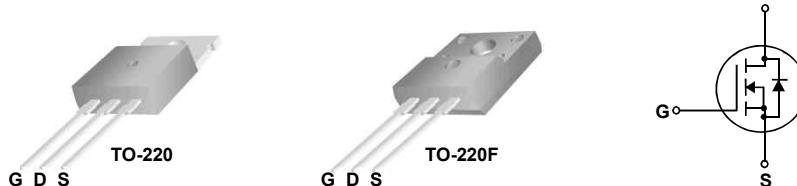
## 500V N-Channel MOSFET

### General Description

This Power MOSFET is produced using Maple semi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

### Features

- 16A, 500V,  $R_{DS(on)typ.} = 305\text{m}\Omega @ V_{GS} = 10\text{V}$
- Low gate charge ( typical 52nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



### Absolute Maximum Ratings

$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	SLP16N50C	SLF16N50C	Units
$V_{DSS}$	Drain-Source Voltage	500		V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )	16.0	16.0 *	A
	- Continuous ( $T_C = 100^\circ\text{C}$ )	9.6	9.6 *	A
$I_{DM}$	Drain Current - Pulsed (Note 1)	64	64 *	A
$V_{GSS}$	Gate-Source Voltage	$\pm 30$		V
EAS	Single Pulsed Avalanche Energy (Note 2)	418		mJ
$I_{AR}$	Avalanche Current (Note 1)	16		A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	23.42		mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ (Note 3)	4.5		V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ )	219	40	W
	- Derate above $25^\circ\text{C}$	1.75	0.33	W/ $^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150		$^\circ\text{C}$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300		$^\circ\text{C}$

\* Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	SLP16N50C	SLF16N50C	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.57	3.07	$^\circ\text{C}/\text{W}$
$R_{\theta JS}$	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^\circ\text{C}/\text{W}$

## Electrical Characteristics

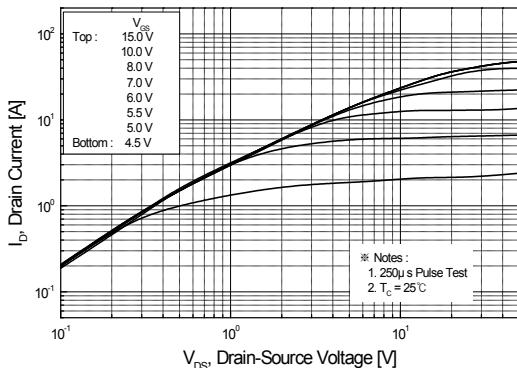
$T_C = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	500	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to $25^\circ\text{C}$	--	0.5	--	$\text{V}/^\circ\text{C}$
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 500 \text{ V}, V_{\text{GS}} = 0 \text{ V}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 400 \text{ V}, T_C = 125^\circ\text{C}$	--	--	10	$\mu\text{A}$
$I_{\text{GSSF}}$	Gate-Body Leakage Current, Forward	$V_{\text{GS}} = 30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	100	nA
$I_{\text{GSSR}}$	Gate-Body Leakage Current, Reverse	$V_{\text{GS}} = -30 \text{ V}, V_{\text{DS}} = 0 \text{ V}$	--	--	-100	nA
<b>On Characteristics</b>						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	3.0	--	5.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}} = 10 \text{ V}, I_D = 8 \text{ A}$	--	305	366	$\text{m}\Omega$
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}} = 40 \text{ V}, I_D = 8 \text{ A}$ (Note 4)	--	11	--	S
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}} = 25 \text{ V}, V_{\text{GS}} = 0 \text{ V}, f = 1.0 \text{ MHz}$	--	2300	--	pF
$C_{\text{oss}}$	Output Capacitance		--	255	--	pF
$C_{\text{rss}}$	Reverse Transfer Capacitance		--	10	--	pF
<b>Switching Characteristics</b>						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 250 \text{ V}, I_D = 16 \text{ A}, R_G = 25 \Omega$ (Note 4, 5)	--	31.5	--	ns
$t_r$	Turn-On Rise Time		--	36.5	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	175	--	ns
$t_f$	Turn-Off Fall Time		--	57	--	ns
$Q_g$	Total Gate Charge	$V_{\text{DS}} = 400 \text{ V}, I_D = 16 \text{ A}, V_{\text{GS}} = 10 \text{ V}$ (Note 4, 5)	--	52	--	nC
$Q_{\text{gs}}$	Gate-Source Charge		--	13	--	nC
$Q_{\text{gd}}$	Gate-Drain Charge		--	22	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_s$	Maximum Continuous Drain-Source Diode Forward Current		--	--	16	A
$I_{\text{SM}}$	Maximum Pulsed Drain-Source Diode Forward Current		--	--	64	A
$V_{\text{SD}}$	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0 \text{ V}, I_s = 16 \text{ A}$	--	--	1.4	V
$t_{\text{rr}}$	Reverse Recovery Time	$V_{\text{GS}} = 0 \text{ V}, I_s = 16 \text{ A}, dI_F / dt = 100 \text{ A/us}$ (Note 4)	--	433	--	ns
$Q_{\text{rr}}$	Reverse Recovery Charge		--	5.13	--	uC

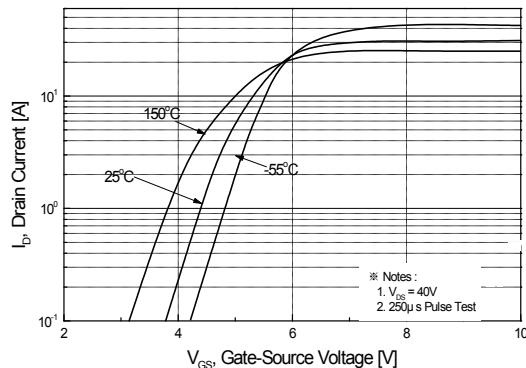
**Notes:**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $L = 3.0\text{mH}$ ,  $I_{AS} = 16\text{A}$ ,  $V_{DD} = 50\text{V}$ ,  $R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
- $I_{SD} \leq 16\text{A}$ ,  $dI/dt \leq 100\text{A/us}$ ,  $V_{DD} \leq \text{BV}_{\text{DSS}}$ , Starting  $T_J = 25^\circ\text{C}$
- Pulse Test : Pulse width  $\leq 300\text{us}$ , Duty cycle  $\leq 2\%$
- Essentially independent of operating temperature

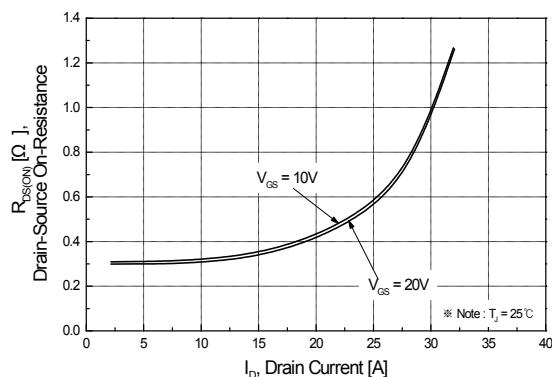
## Typical Characteristics



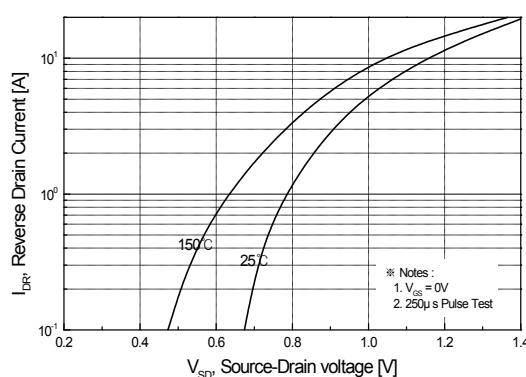
**Figure 1. On-Region Characteristics**



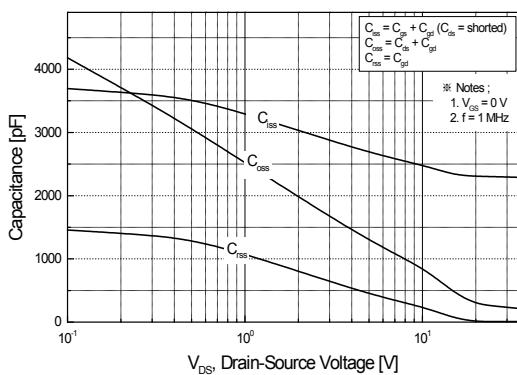
**Figure 2. Transfer Characteristics**



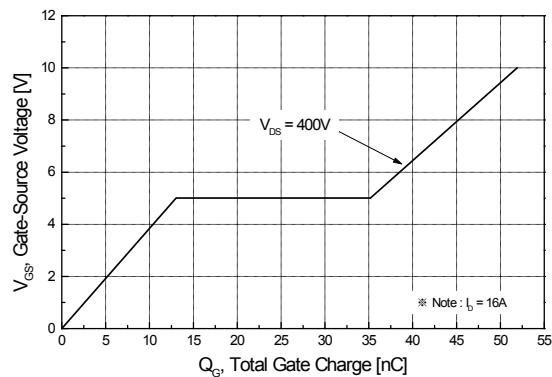
**Figure 3. On-Resistance Variation vs  
Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage  
Variation with Source Current  
and Temperature**

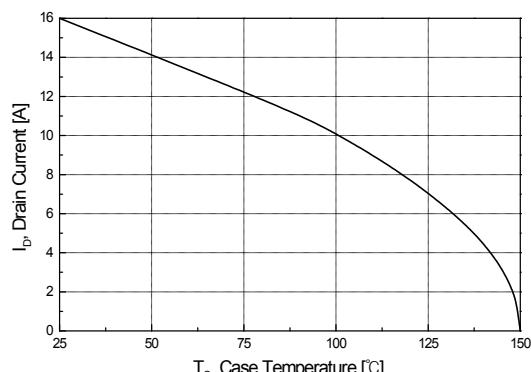
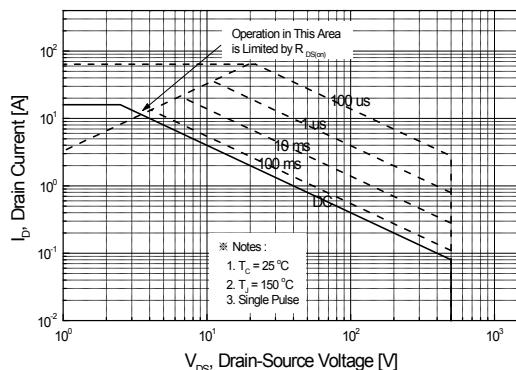
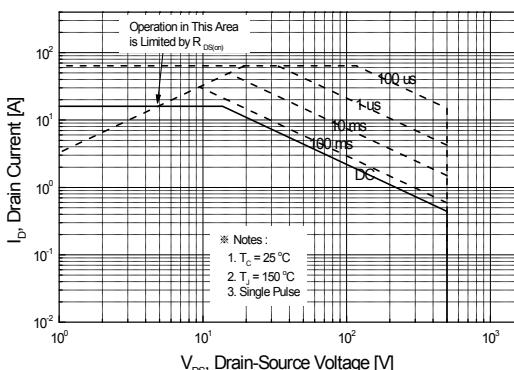
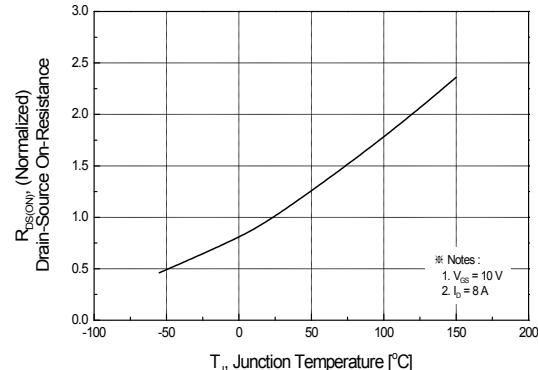
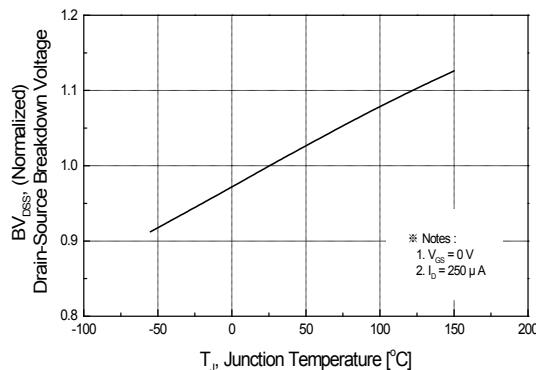


**Figure 5. Capacitance Characteristics**



**Figure 6. Gate Charge Characteristics**

## Typical Characteristics (Continued)



## Typical Characteristics (Continued)

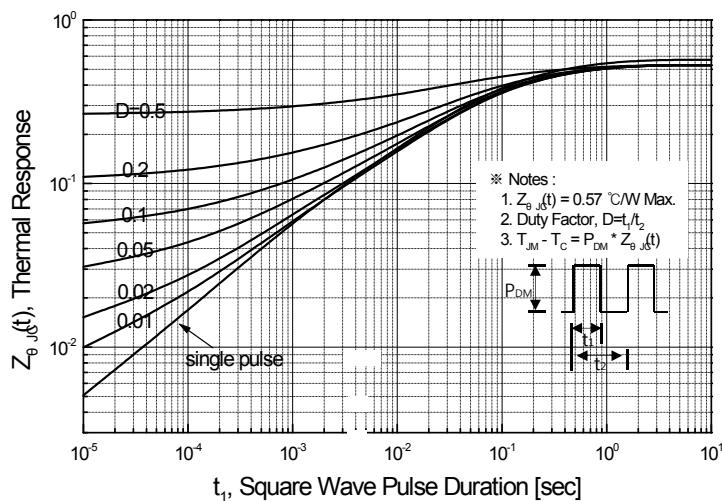


Figure 11-1. Transient Thermal Response Curve for SLP16N50C

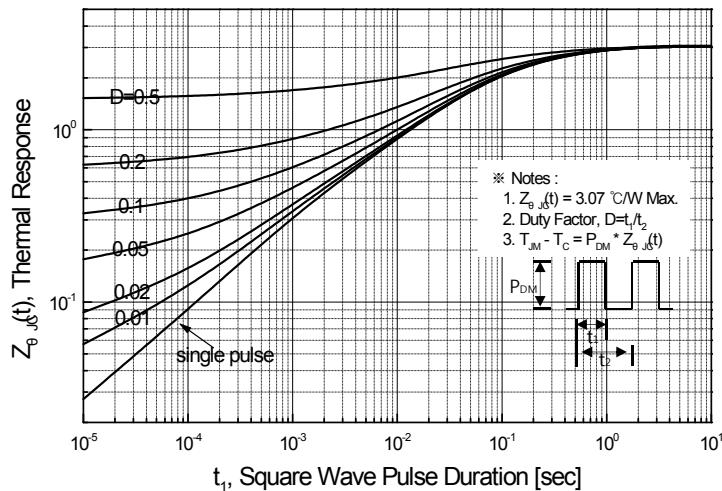
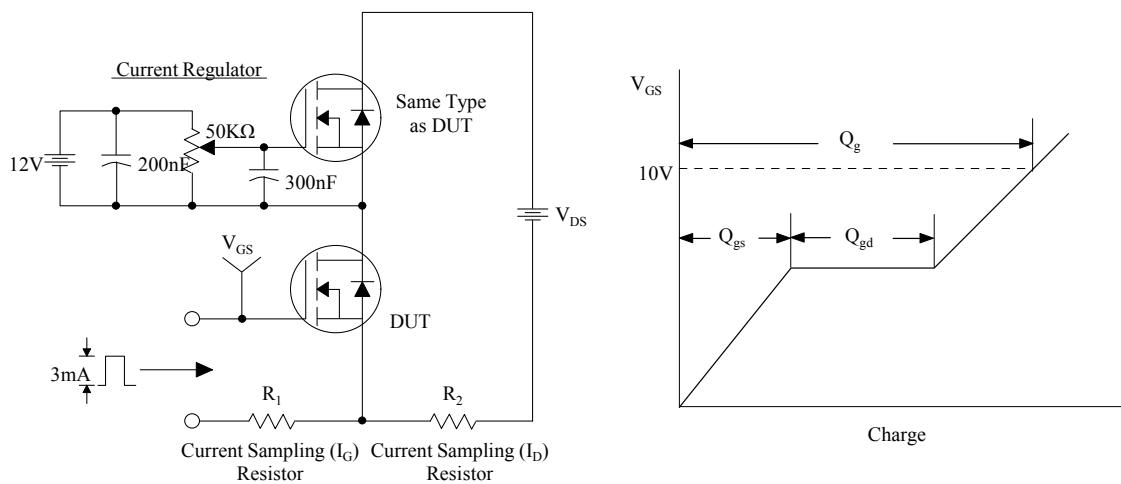
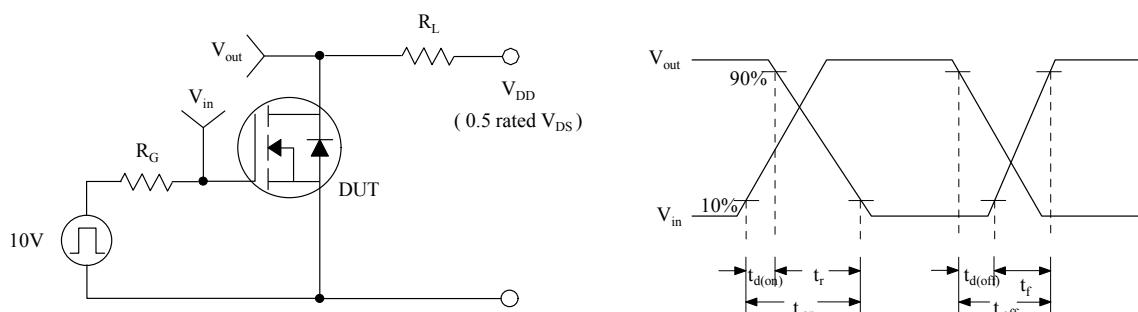


Figure 11-2. Transient Thermal Response Curve for SLF16N50C

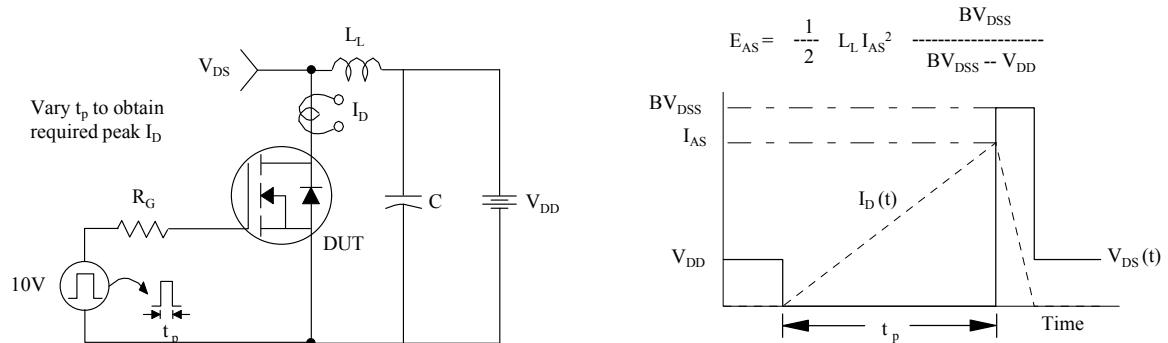
### Gate Charge Test Circuit & Waveform



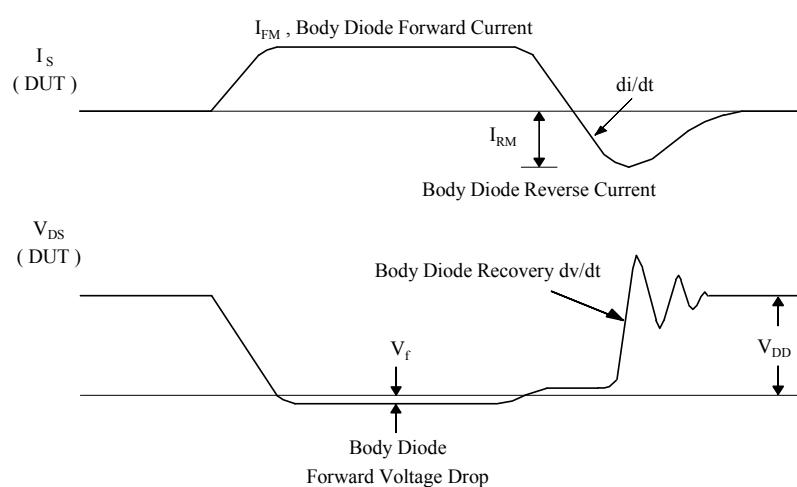
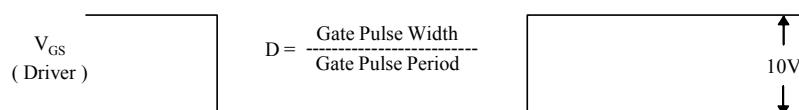
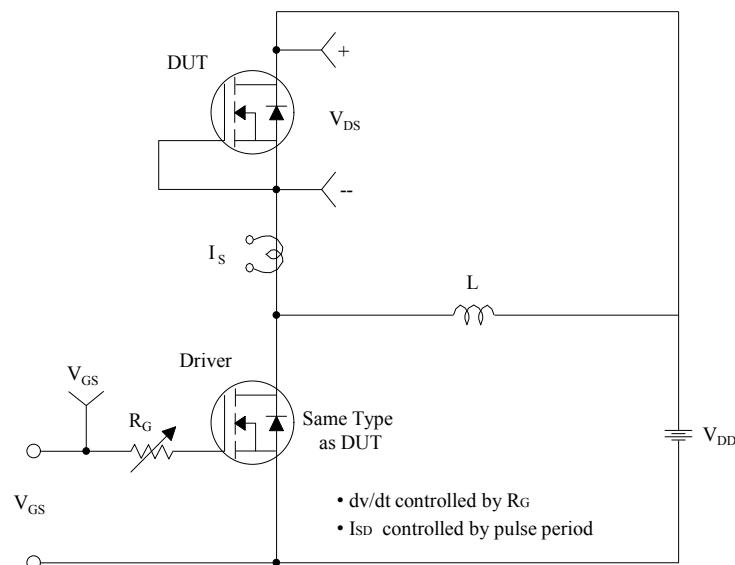
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms



### Peak Diode Recovery dv/dt Test Circuit & Waveforms



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